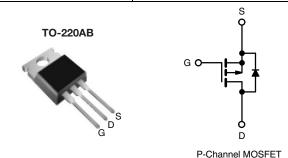


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	- 20	- 200			
R _{DS(on)} (Ω)	V _{GS} = - 10 V	0.50			
Q _g (Max.) (nC)	44	1			
Q _{gs} (nC)	7.	1			
Q _{gd} (nC)	27	27			
Configuration	Sing	Single			



FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF9640PbF
	SiHF9640-E3
SnPb	IRF9640
	SiHF9640

ABSOLUTE MAXIMUM RATINGS (To	; = 25 °C, unle	ess otherwis	e noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	- 200	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V -1 40 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		- 11		
	V _{GS} at - 10 V	T _C = 100 °C	I _D	- 6.8	Α	
Pulsed Drain Current ^a			I _{DM}	- 44		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	700	mJ	
Repetitive Avalanche Current ^a			I _{AR}	- 11	А	
Repetitive Avalanche Energy ^a			E _{AR}	13	mJ	
Maximum Power Dissipation	$T_C = 3$	25 °C	P_{D}	125	W	
Peak Diode Recovery dV/dt ^c			dV/dt	- 5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = -50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 8.7 \,\text{mH}$, $R_g = 25 \,\Omega$, $I_{AS} = -11 \,\text{A}$ (see fig. 12).
- c. $I_{SD} \le -11 \text{ A}$, $dI/dt \le 150 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 150 \,^{\circ}\text{C}$.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	62	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W
Maximum Junction-to-Case (Drain)	R_{thJC}	-	1.0	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static						•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	- 200	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = - 1 mA		-	-0.2	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA		- 2.0	-	- 4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V		-	± 100	nA
Zero Gate Voltage Drain Current		V _{DS} =	V _{DS} = - 200 V, V _{GS} = 0 V		-	- 100	μA
Zero date voltage Drain ourrent	I _{DSS}	V _{DS} = - 160	$V, V_{GS} = 0 V, T_{J} = 125 ^{\circ}C$	ı	-	- 500	μΛ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	$I_D = -6.6 A^b$	ı	-	0.50	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	V _{DS} = - 50 V, I _D = - 6.6 A ^b		-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$		-	1200	-	pF
Output Capacitance	C _{oss}			-	370	-	
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	81	-	
Total Gate Charge	Q_g		1 11 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	-	-	44	
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V	$I_D = -11 \text{ A}, V_{DS} = -160 \text{ V},$ see fig. 6 and 13^b	-	-	7.1	nC
Gate-Drain Charge	Q _{gd}			ı	-	27	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = \text{- }100 \text{ V, } I_D = \text{- }11 \text{ A}$ $R_g = 9.1 \Omega, R_D = 8.6 \Omega, \text{ see fig. }10^b$		-	14	-	- ns
Rise Time	t _r			-	43	-	
Turn-Off Delay Time	t _{d(off)}			-	39	-	
Fall Time	t _f			-	38	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	m1.1
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s					•	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		ı	-	- 11	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 44	^
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = - 11 A, V _{GS} = 0 V ^b		-	-	- 5	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = -11 \text{A}, \text{dI/dt} = 100 \text{A/} \mu \text{s}^b$		-	250	300	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.9	3.6	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is domin				y L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

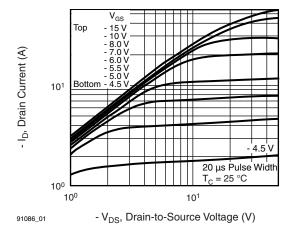


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

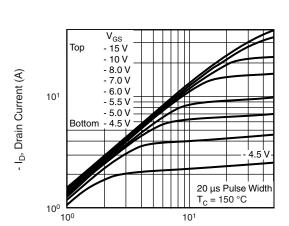


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

- V_{DS} , Drain-to-Source Voltage (V)

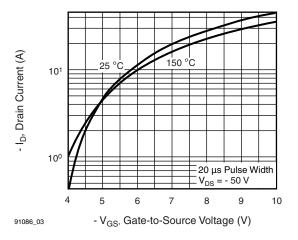


Fig. 3 - Typical Transfer Characteristics

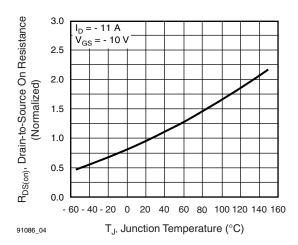


Fig. 4 - Normalized On-Resistance vs. Temperature

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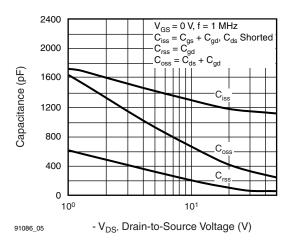


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

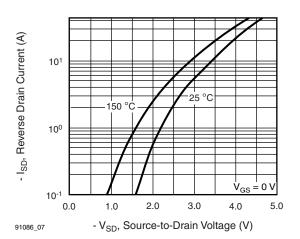


Fig. 7 - Typical Source-Drain Diode Forward Voltage

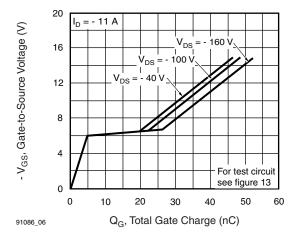


Fig. 6 - Typical Gate Charge vs. Drain-to-Source Voltage

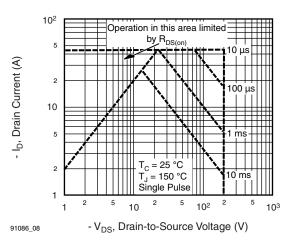


Fig. 8 - Maximum Safe Operating Area



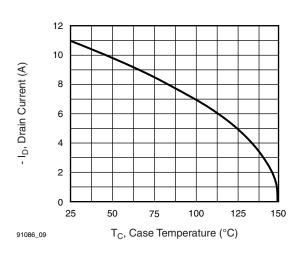


Fig. 9 - Maximum Drain Current vs. Case Temperature

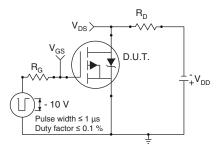


Fig. 10a - Switching Time Test Circuit

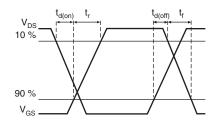


Fig. 10b - Switching Time Waveforms

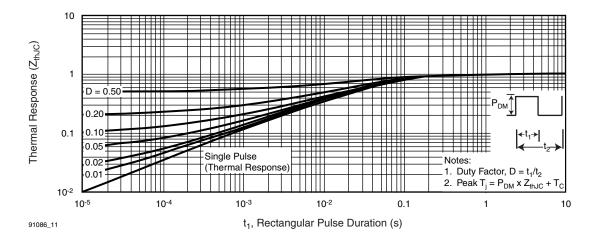


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



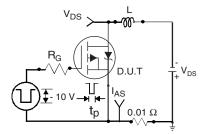


Fig. 12a - Unclamped Inductive Test Circuit

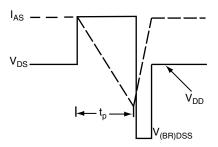


Fig. 12b - Unclamped Inductive Waveforms

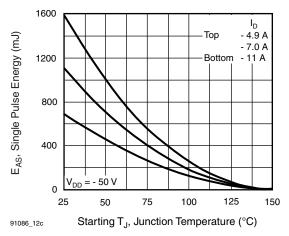


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

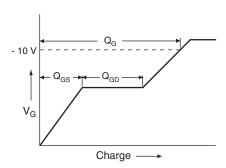


Fig. 13a - Basic Gate Charge Waveform

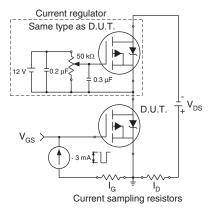
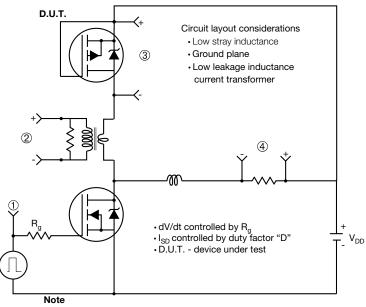


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



· Compliment N-Channel of D.U.T. for driver

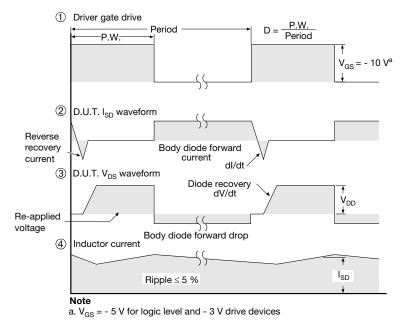


Fig. 14 - For P-Channel

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